## Notice of References Cited Application/Control No. 10/042,595 Examiner Jonathan Liou Applicant(s)/Patent Under Reexamination ELOY ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,393,007	05-2002	Haartsen, Jacobus C.	370/337
	В	US-3,908,087	09-1975	Krol, Thijs	370/375
	С	US-6,356,763	03-2002	Kangas et al.	455/456.1
	D	US-6,785,510	08-2004	Larsen, James David	455/11.1
	E	US-5,369,664	11-1994	Takahashi et al.	375/138
	F	US-6,741,579	05-2004	Choi et al.	370/337
	G	US-6,400,704	06-2002	Mikuni et al.	370/347
	н	US-			
	1	US-			
	J	US-			
	к	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q	• .				
	R					
	S					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	υ	
	<b>V</b>	
	w	
	х	

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